Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from,Europe,America and south Asia,supplying obsolete and hard-to-find components to meet their specific needs.

With the principle of “Quality Parts,Customers Priority,Honest Operation,and Considerate Service”,our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip,ALPS,ROHM,Xilinx,Pulse,ON,Everlight and Freescale. Main products comprise IC,Modules,Potentiometer,IC Socket,Relay,Connector.Our parts cover such applications as commercial,industrial, and automotives areas.

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NIF62514

Self-Protected FET with Temperature and Current Limit

HDPlus devices are an advanced series of power MOSFETs which utilize ON Semiconductor's latest MOSFET technology process to achieve the lowest possible on−resistance per silicon area while incorporating smart features. Integrated thermal and current limits work together to provide short circuit protection. The devices feature an integrated Drain−to−Gate Clamp that enables them to withstand high energy in the avalanche mode. The Clamp also provides additional safety margin against unexpected voltage transients. Electrostatic Discharge (ESD) protection is provided by an integrated Gate−to−Source Clamp.

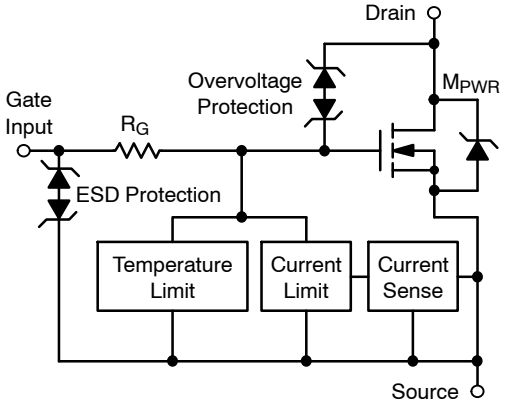
Features

- Current Limitation
- Thermal Shutdown with Automatic Restart
- Short Circuit Protection
- Low $R_{DS(on)}$
- I_{DSS} Specified at Elevated Temperature
- Avalanche Energy Specified
- Slew Rate Control for Low Noise Switching
- Overvoltage Clamped Protection
- This is a Pb−Free Device

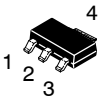
ON Semiconductor®

http://onsemi.com

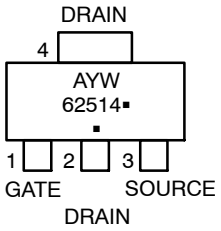
6.0 AMPERES*
40 VOLTS CLAMPED
$R_{DS(on)}$ = 90 mΩ



MARKING DIAGRAM



SOT−223
CASE 318E
STYLE 3



A = Assembly Location
Y = Year
W = Work Week
62514 = Specific Device Code
▪ = Pb−Free Package
(Note: Microdot may be in either location)

ORDERING INFORMATION

Device	Package	Shipping†
NIF62514T1G	SOT−223 (Pb−Free)	1000/Tape & Reel
NIF62514T3G	SOT−223 (Pb−Free)	4000/Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

*Limited by the current limit circuit.

MOSFET MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Rating	Symbol	Value	Unit
Drain−to−Source Voltage Internally Clamped	V_{DSS}	40	Vdc
Drain−to−Gate Voltage Internally Clamped (R_{GS} = 1.0 MΩ)	V_{DGR}	40	Vdc
Gate−to−Source Voltage	V_{GS}	±16	Vdc
Drain Current − Continuous @ T_A = 25°C − Continuous @ T_A = 100°C − Pulsed ($t_p \le 10$ μs)	 I_D I_D I_{DM}	Internally Limited	
Total Power Dissipation @ T_A = 25°C (Note 1) @ T_A = 25°C (Note 2) @ T_A = 25°C (Note 3)	P_D	 1.1 1.73 8.93	W
Thermal Resistance, Junction−to−Tab Junction−to−Ambient (Note 1) Junction−to−Ambient (Note 2)	 $R_{\theta JT}$ $R_{\theta JA}$ $R_{\theta JA}$	 14 114 72.3	°C/W
Single Pulse Drain−to−Source Avalanche Energy (V_{DD} = 25 Vdc, V_{GS} = 5.0 Vdc, V_{DS} = 40 Vdc, I_L = 2.8 Apk, L = 80 mH, R_G = 25 Ω)	E_{AS}	300	mJ
Operating and Storage Temperature Range	T_J, T_{stg}	−55 to 150	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

1. Mounted onto min pad board.
2. Mounted onto 1″ pad board.
3. Mounted onto large heatsink.

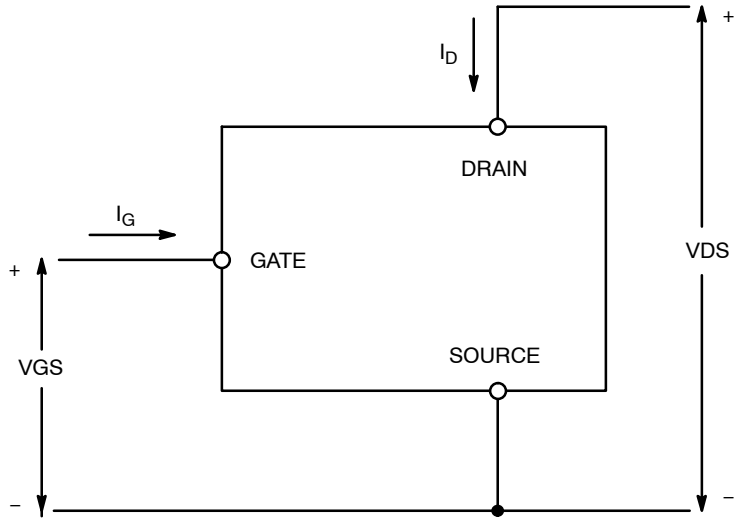


Figure 1. Voltage and Current Convention

MOSFET ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
OFF CHARACTERISTICS					
Drain−to−Source Clamped Breakdown Voltage (V_{GS} = 0 Vdc, I_D = 250 μAdc) (V_{GS} = 0 Vdc, I_D = 250 μAdc, T_J = 150°C) (Note 4)	$V_{(BR)DSS}$	 42 42	 46 45	 50 50	Vdc
Zero Gate Voltage Drain Current (V_{DS} = 32 Vdc, V_{GS} = 0 Vdc) (V_{DS} = 32 Vdc, V_{GS} = 0 Vdc, T_J = 150°C) (Note 4)	I_{DSS}	 − −	 0.5 2.0	 2.0 10	μAdc
Gate Input Current (V_{GS} = 5.0 Vdc, V_{DS} = 0 Vdc) (V_{GS} = −5.0 Vdc, V_{DS} = 0 Vdc)	I_{GSS}	 − −	 50 550	 100 1000	μAdc
ON CHARACTERISTICS					
Gate Threshold Voltage (V_{DS} = V_{GS}, I_D = 150 μAdc) Threshold Temperature Coefficient (Negative)	$V_{GS(th)}$	1.0 −	1.7 4.0	2.0 −	Vdc mV/°C
Static Drain−to−Source On−Resistance (Note 5) (V_{GS} = 10 Vdc, I_D = 1.4 Adc, T_J @ 25°C) (V_{GS} = 10 Vdc, I_D = 1.4 Adc, T_J @ 150°C) (Note 4)	$R_{DS(on)}$	 − −	 90 165	 100 190	mΩ
Static Drain−to−Source On−Resistance (Note 5) (V_{GS} = 5.0 Vdc, I_D = 1.4 Adc, T_J @ 25°C) (V_{GS} = 5.0 Vdc, I_D = 1.4 Adc, T_J @ 150°C) (Note 4)	$R_{DS(on)}$	 − −	 105 185	 120 210	mΩ
Source−Drain Forward On Voltage (I_S = 7 A, V_{GS} = 0 V)	V_{SD}	−	1.05	−	V

SWITCHING CHARACTERISTICS (Note 4)

Turn−on Delay Time	10% V_{in} to 10% I_D R_L = 4.7 Ω, V_{in} = 0 to 10 V, V_{DD} = 12 V	$t_{d(on)}$	−	4.0	8.0	μs
Turn−on Rise Time	10% I_D to 90% I_D R_L = 4.7 Ω, V_{in} = 0 to 10 V, V_{DD} = 12 V	t_{rise}	−	11	20	μs
Turn−off Delay Time	90% V_{in} to 90% I_D R_L = 4.7 Ω, V_{in} = 10 to 0 V, V_{DD} = 12 V	$t_{d(off)}$	−	32	50	μs
Turn−off Fall Time	90% I_D to 10% I_D R_L = 4.7 Ω, V_{in} = 10 to 0 V, V_{DD} = 12 V	t_{fall}	−	27	50	μs
Slew−Rate On	R_L = 4.7 Ω, V_{in} = 0 to 10 V, V_{DD} = 12 V	$-dV_{DS}/dt_{on}$	−	1.5	2.5	μs
Slew−Rate Off	R_L = 4.7 Ω, V_{in} = 10 to 0 V, V_{DD} = 12 V	dV_{DS}/dt_{off}	−	0.6	1.0	μs

SELF PROTECTION CHARACTERISTICS (T_J = 25°C unless otherwise noted)

Current Limit	(V_{GS} = 5.0 Vdc) (V_{GS} = 5.0 Vdc, T_J = 150°C) (Note 4)	I_{LIM}	6.0 3.0	9.0 5.0	11 8.0	Adc
Current Limit	(V_{GS} = 10 Vdc) (V_{GS} = 10 Vdc, T_J = 150°C) (Note 4)	I_{LIM}	7.0 4.0	10.5 7.5	13 10	Adc
Temperature Limit (Turn−off) (Note 4)	V_{GS} = 5.0 Vdc	$T_{LIM(off)}$	150	175	200	°C
Temperature Hysteresis (Note 4)	V_{GS} = 5.0 Vdc	$\Delta T_{LIM(on)}$	−	15	−	°C
Temperature Limit (Turn−off) (Note 4)	V_{GS} = 10 Vdc	$T_{LIM(off)}$	150	165	185	°C
Temperature Hysteresis (Note 4)	V_{GS} = 10 Vdc	$\Delta T_{LIM(on)}$	−	15	−	°C

ESD ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

Electro−Static Discharge Capability	Human Body Model (HBM)	ESD	4000	−	−	V
Electro−Static Discharge Capability	Machine Model (MM)	ESD	400	−	−	V

4. Not subject to production testing.
5. Pulse Test: Pulse Width = 300 μs, Duty Cycle = 2%.

TYPICAL ELECTRICAL CHARACTERISTICS

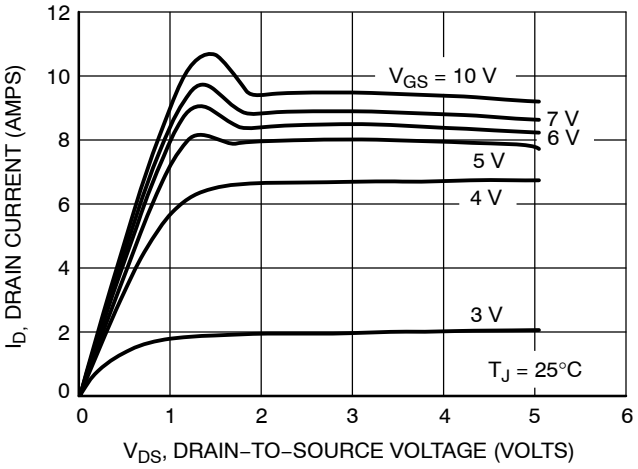


Figure 1. Output Characteristics

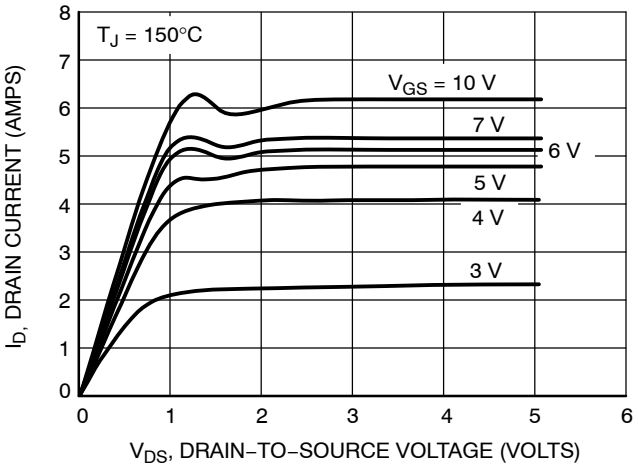


Figure 2. Output Characteristics

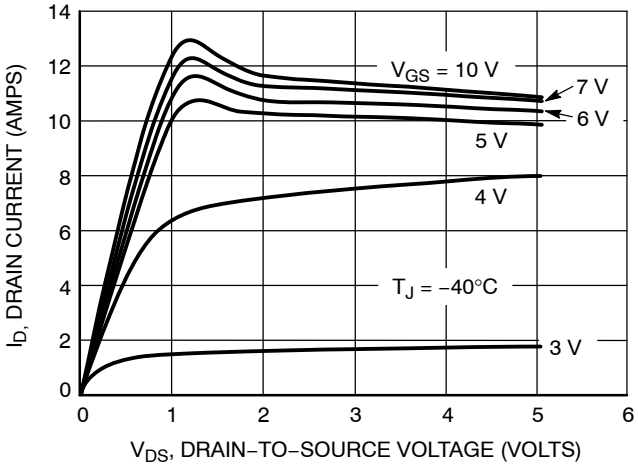


Figure 3. Output Characteristics

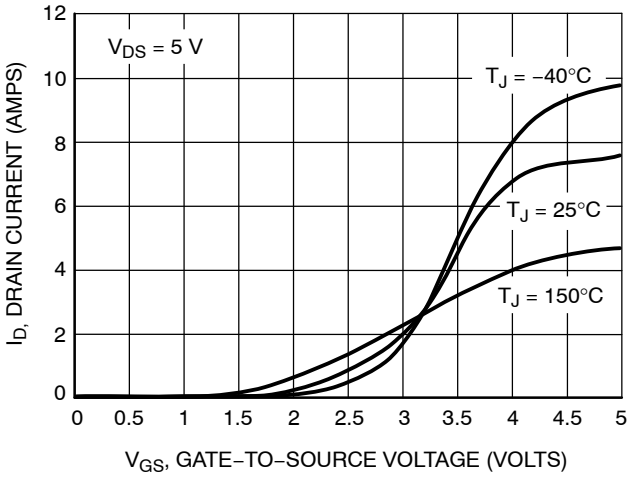


Figure 4. Transfer Characteristics

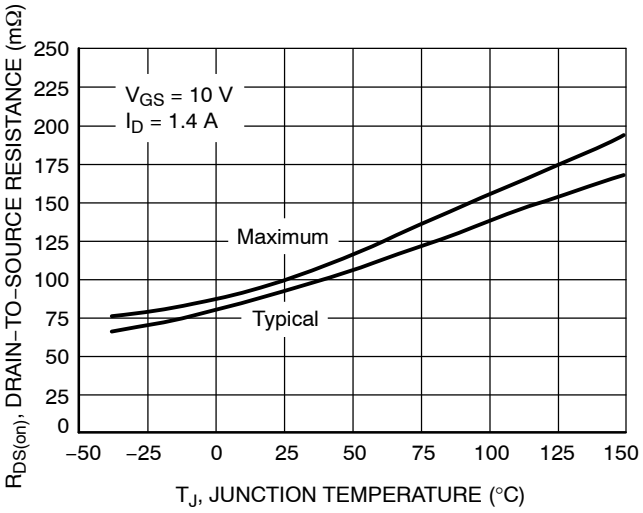


Figure 5. Drain−to−Source Resistance versus Junction Temperature

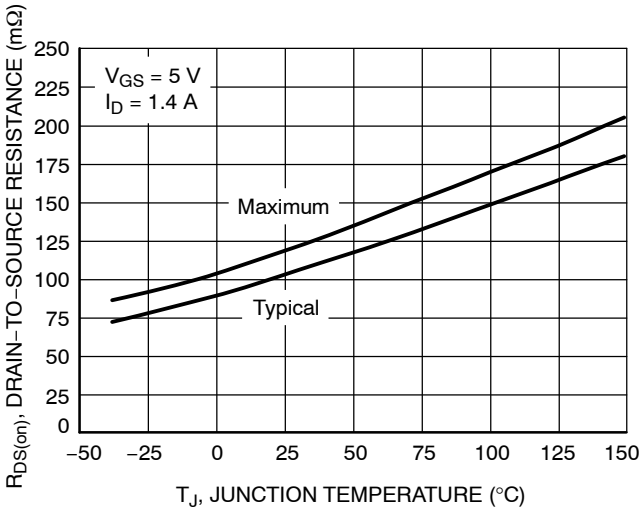


Figure 6. Drain−to−Source Resistance versus Junction Temperature

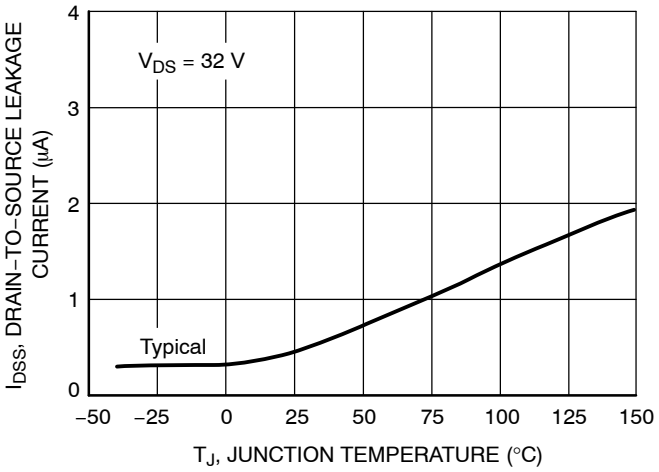


Figure 7. Drain−to−Source Resistance versus Junction Temperature

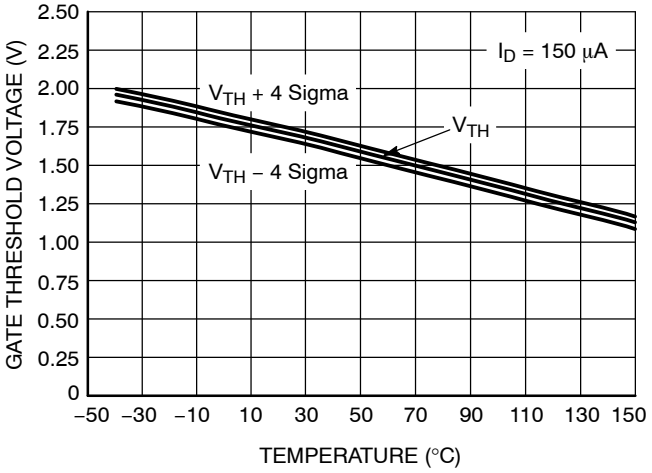


Figure 8. Gate Threshold Voltage versus Temperature

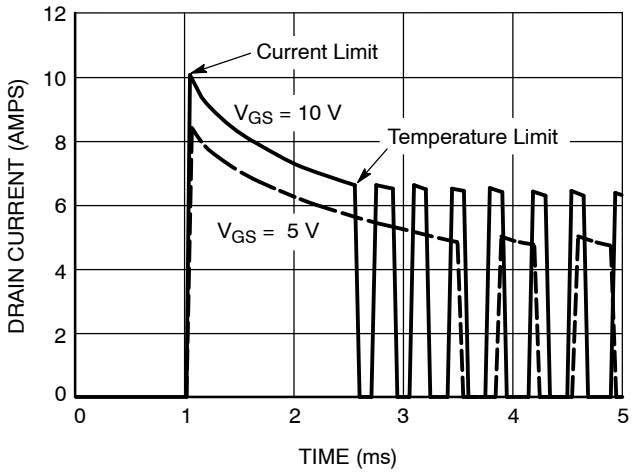


Figure 9. Short−circuit Response

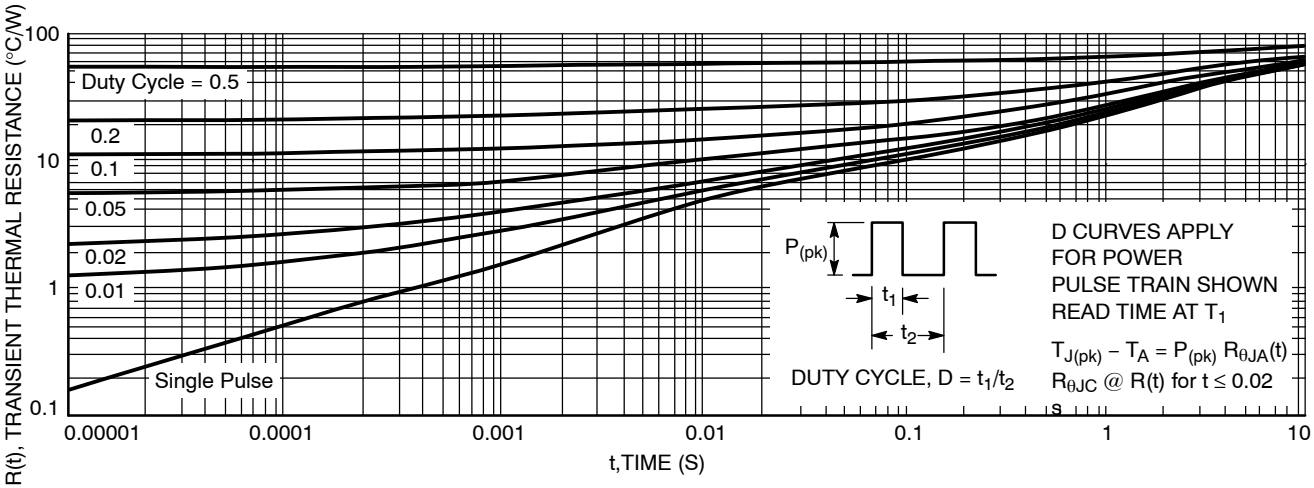
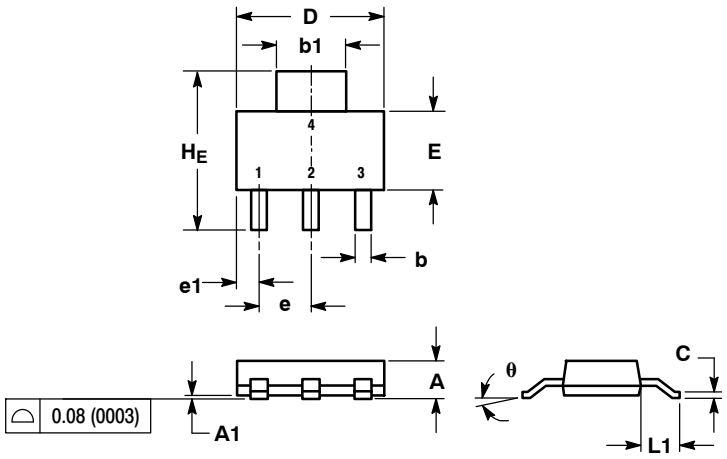


Figure 10. Transient Thermal Resistance (Non−normalized Junction−to−Ambient mounted on minimum pad area)

PACKAGE DIMENSIONS

SOT−223 (TO−261)
CASE 318E−04
ISSUE M

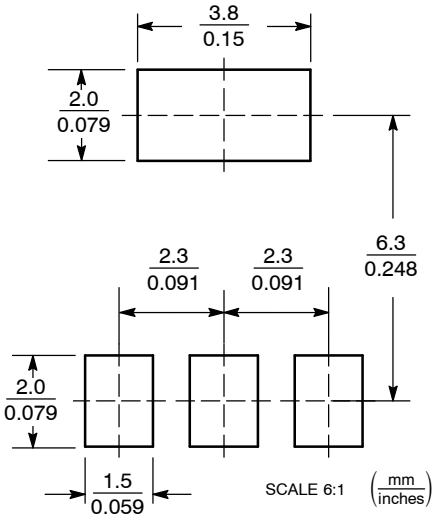


NOTES:
1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
2. CONTROLLING DIMENSION: INCH.

	MILLIMETERS			INCHES		
DIM	MIN	NOM	MAX	MIN	NOM	MAX
A	1.50	1.63	1.75	0.060	0.064	0.068
A1	0.02	0.06	0.10	0.001	0.002	0.004
b	0.60	0.75	0.89	0.024	0.030	0.035
b1	2.90	3.06	3.20	0.115	0.121	0.126
c	0.24	0.29	0.35	0.009	0.012	0.014
D	6.30	6.50	6.70	0.249	0.256	0.263
E	3.30	3.50	3.70	0.130	0.138	0.145
e	2.20	2.30	2.40	0.087	0.091	0.094
e1	0.85	0.94	1.05	0.033	0.037	0.041
L1	1.50	1.75	2.00	0.060	0.069	0.078
H_E	6.70	7.00	7.30	0.264	0.276	0.287
θ	0°	–	10°	0°	–	10°

STYLE 3:
PIN 1. GATE
2. DRAIN
3. SOURCE
4. DRAIN

SOLDERING FOOTPRINT



*For additional information on our Pb−Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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